innodisk

CFexpress 3TE8 Series

Customer:	
Customer	
Part	
Number:	
Innodisk	
Part	
Number:	
Innodisk	
Model Name:	
Date:	

Innodisk	Customer
Approver	Approver

Total Solution For Industrial Flash Storage



Features:

- PCIe Gen 3 x2, NVMe SSD
- Innodisk 3D TLC NAND
- Standard temperature
- iPower Guard
- iData Guard
- Dynamic Thermal Management
- Hybrid Write Mode with SLC Cache Enable
- Support TCG OPAL function

Performance:

- Sequential Read up to 1,750 MB/s
- Sequential Write up to 1,650 MB/s

Power Requirements:

Input Voltage:	3.3V± 5%
Max Operating Wattage (R/W):	3.2W
Idle Wattage:	0.5W

Reliability:

Capacity	TBW (Client)	DWPD
128GB	86	0.7
256GB	192 0.8	
512GB	361	0.5
1TB	803	0.5

Data Retention	1 Year
Warranty	3 Years

1 year data retention is at NAND life end.

For warranty details, please refer to:

https://www.innodisk.com/en/support_and_service/warranty

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REVISION HISTORY

Revision	Description Date	
V1.0	First Release	Nov., 2024
V1.1	Update Transfer Mode Ja	

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1. Product Overview

1.1 Introduction of Innodisk CFexpress 3TE8

Innodisk CFexpress 3TE8 is a NVM Express DRAM-less SSD designed with PCIe interface and industrial 3D TLC NAND Flash. CFexpress 3TE8 supports PCIe Gen 3 x2 and it is compliant with NVMe 1.4 providing excellent top and also sustained performance. With sophisticated error detection and correction (ECC) functions, the module can provide full End-to-end Data Path Protection that secures the data transmission between the host system and NAND Flash.

Innodisk CFexpress 3TE8 is designed with AES engine, which is a built in controller. When controller receives the data package from host, AES engine encrypts the data package and saves the encrypted data into NAND flash. Thus, unauthorized personal has no access to decrypt the data in NAND flash.

1.2 Product View and Models

Innodisk CFexpress 3TE8 is available in follow capacities with industrial 3D TLC flash ICs.

CFexpress 3TE8 128GB CFexpress 3TE8 256GB CFexpress 3TE8 512GB CFexpress 3TE8 1TB



Figure 1: Innodisk CFexpress 3TE8

1.3 PCIe Interface

Innodisk CFexpress 3TE8 supports PCIe Gen 3 interface and compliant with NVMe 1.4. CFexpress 3TE8 can work under PCIe Gen 1, Gen 2 and Gen 3.

Most of operating system includes NVMe in-box driver now. For more information about the driver support in each OS, please visit <u>https://nvmexpress.org/drivers/</u>.



2. Product Specifications

2.1 Capacity and Device Parameters

CFexpress 3TE8 device parameters are shown in Table 1.

Capacity	Cylinders	Heads	Sectors	LBA	User Capacity(MB)		
128GB				234441648	114473		
256GB	16202	16	1.5	10	62	468862128	228937
512GB	16383		63	937703088	457863		
1TB				1875385008	915715		

Table 1: Device parameters

2.2 Performance

Burst Transfer Rate: 2 GB/s

Table 2: Performance-	112 Layers 3D TLC
------------------------------	-------------------

Capacity	Unit	128GB	256GB	512GB	1ТВ
Sequential*		1,450	1,750	1,750	1,750
Read (Q8T1)		1,430	1,750	1,750	1,750
Sequential*		530	1 050	1,000	1 650
Write (Q8T1)		020	1,050	1,000	1,650
Sustained	MB/s				
Sequential Read		550	980	870	1,000
(Avg.)***					
Sustained					
Sequential Write		170	340	310	400
(Avg.)***					
4KB Random**		45.000	02.000	86.000	221 000
Read (Q32T16)	IOPS	45,000	92,000	86,000	321,000
4KB Random**		116.000	222.000	208.000	216.000
Write (Q32T16)		116,000	222,000	208,000	316,000

Note: * Performance results are 3TE8 with Innodisk BiCS5 NAND composition measured in Room Temperature with Out-of-Box devices and may vary depending on overall system setup. In addition, 3TE8 series adopt hybrid mode which enables SLC cache followed by TLC direct write to strike balance between burst performance and steady overall stability. Note: ** Performance results are based on CrystalDiskMark 8.0.1 with file size 1000MB. Unit of 4KB item is IOPS. Note: *** Performance results are based on AIDA 64 v5.98 with block size 1MB of Linear Read & Write Test Item.

2.3 Electrical Specifications

2.3.1 Power Requirement

Table 3: Innodisk CFexpress 3TE8 Power Requirement

Item	Symbol	Rating	Unit
Input voltage	VIN	+3.3 DC +- 5%	V

2.3.2 Power Consumption

Mode	Power Consumption (W)
Read	3.2
Write	3.0
Idle	0.5
Power-on peak	4.2

Table 4: Power Consumption

Target: CFexpress 3TE8 1TB

Note: Current results may vary depending on system components and power circuit design. Please refer to the test report for other capacities.

2.4 Environmental Specifications

2.4.1 Temperature Ranges

Table 5: Temperature range for CFexpress 3TE8

Temperature Range	
Operating	Standard Grade: 0°C to +70°C
Storage	-40°C to +85°C

2.4.2 Humidity

Relative Humidity: 10-95%, non-condensing

2.4.3 Shock and Vibration

Table 6: Shock/Vibration Testing for CFexpress 3TE8

Reliability Test Conditions		Reference Standards
Vibration	7 Hz to 2K Hz, 20G, 3 axes	IEC 60068-2-6
Mechanical Shock	Duration: 0.5ms, 1500 G, 3 axes	IEC 60068-2-27



2.4.4 Mean Time between Failures (MTBF)

Table 7 summarizes the MTBF prediction results for various CFexpress 3TE8 configurations. The analysis was performed using a RAM Commander[™] failure rate prediction.

- **Failure Rate**: The total number of failures within an item population, divided by the total number of life units expended by that population, during a particular measurement interval under stated condition.
- **Mean Time between Failures (MTBF)**: A basic measure of reliability for repairable items: The mean number of life units during which all parts of the item perform within their specified limits, during a particular measurement interval under stated conditions.

Product	Condition	MTBF (Hours)
Innodisk CFexpress 3TE8	Telcordia SR-332 GB, 25°C	>3,000,000

2.5 CE and FCC Compatibility

CFexpress 3TE8 conforms to CE and FCC requirements.

Table 8: CFexpress 31	E8	ESD
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Reliability	Reference standards
Electrostatic Discharge (ESD)	IEC 61000-4-2 ESD

2.6 RoHS Compliance

CFexpress 3TE8 is fully compliant with RoHS directive.



2.7 Reliability

Table 9: CFexpress 3TE8 TBW

Value		
Unlimited Read Cycles		
3,000 P/E cycles		
Support(LDPC)		
Under 40°C: 1 Year at NAND Life End		
TBW* (Total Bytes Written) Unit: TB		
Sequential workload	Client workload	
341	86	
682	192	
1364	361	
2727	803	
	Unlimited Read Cycles 3,000 P/E cycles Support(LDPC) Under 40°C: 1 Year at NAND Life End Sequential workload 341 682 1364	

* Note:

- 1. Sequential: Mainly sequential write are estimated by PassMark Burnin Test v8.1 pro.
- 2. Client: Follow JESD218 Test method and JESD219A Workload, tested by ULINK. (The capacity lower than 64GB client workload is not specified in JEDEC219A, the values are estimated.)
- 3. Based on out-of-box performance.

2.8 Transfer Mode

CFexpress 3TE8 support following transfer mode:

PCIe Gen 3: 2 GB/s PCIe Gen 2: 1 GB/s PCIe Gen 1: 500 MB/s



2.9 Pin Assignment

Innodisk CFexpress 3TE8 follows CFexpress 1.0 type B pinout define. See Table 10 for CFexpress 3TE8 pin assignment.

Pin No.	Signal #	I/O
21	GND	
20	PETp0	Ι
19	PETn0	Ι
18	GND	
17	PERp0	0
16	PERn0	0
15	GND	
14	REFCLK+	I
13	REFCLK-	I
12	INS#	0
11	CLKREQ#	0
10	+3.3V	
9	PERST#	Ι
8	Reserved (Optional for SMBus data)	I
7	Reserved (Optional for SMBus CLK)	Ι
6	PETp1	Ι
5	PETn1	Ι
4	GND	
3	PERp1	0
2	PERn1	0
1	GND	

Table 10: Innodisk CFexpress 3TE8 Pin Assignment



2.10 Mechanical Dimensions

CFexpress Type B

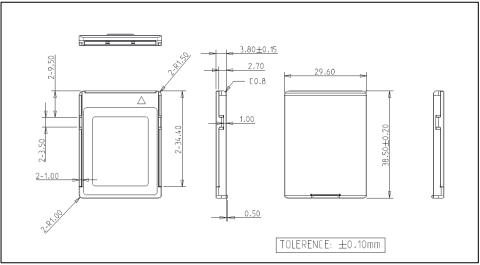


Figure 2: Innodisk CFexpress 3TE8 Mechanical Drawing

CFexpress Type B with WP switch

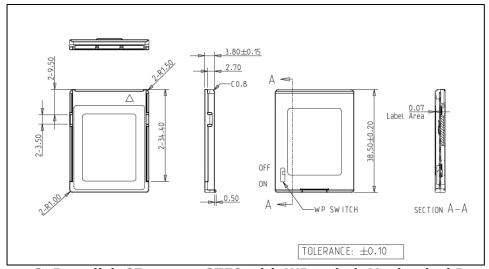


Figure 3: Innodisk CFexpress 3TE8 with WP switch Mechanical Drawing

2.11 Assembly Weight

An Innodisk CFexpress 3TE8 within NAND flash ICs, 128GB's weight is 14 grams approximately.

2.12 Seek Time

Innodisk CFexpress 3TE8 is not of magnetic rotating design. There is no seek or rotational latency.

2.13 NAND Flash Memory

Innodisk CFexpress 3TE8 uses industrial 3D TLC NAND flash memory, which is non-volatility, high reliability and high speed memory storage.



3. Theory of Operation

3.1 Overview

Figure 4 shows the operation of Innodisk CFexpress 3TE8 from the system level, including the major hardware blocks.

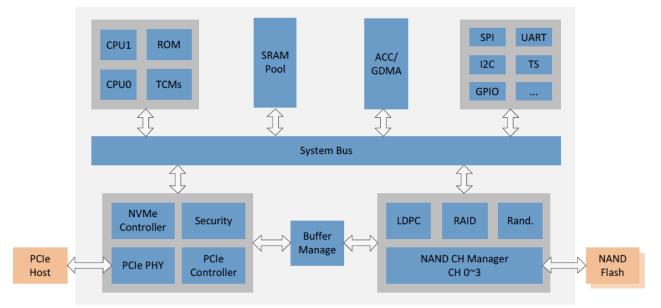


Figure 4: Innodisk CFexpress 3TE8 Block Diagram

Innodisk CFexpress 3TE8 integrates a PCIe Gen 3 x2 controller and NAND flash memories. Communication with the host occurs through the host interface, using the standard NVM protocol. Communication with the flash device(s) occurs through the flash interface.

3.2 PCIe Gen 3 x2 Controller

Innodisk CFexpress 3TE8 is designed with innodisk ID310, a PCIe Gen 3 x2 controller which is compliant with NVMe 1.4, up to 32.0Gbps transfer speed. In addition, it is compliant with PCIe Gen 1, Gen 2 and Gen 3 specification. The controller supports up to four channels for flash interface.

3.3 Error Detection and Correction

Innodisk CFexpress 3TE8 is designed with hardware LDPC ECC engine with hard-decision and soft-decision decoding. Low-density parity-check (LDPC) codes have excellent error correcting performance close to the Shannon limit when decoded with the belief-propagation (BP) algorithm using soft-decision information.

3.4 Wear-Leveling

Flash memory can be erased with a limited number of cycles. This number is called the **erase cycle limit** or **write endurance limit** and is defined by the flash NAND vendor. The erase cycle limit applies to each individual erase block in the flash device.

Innodisk CFexpress 3TE8 uses a combination of two types of wear leveling- dynamic and static wear leveling- to distribute write cycling across an SSD and balance erase count of each block, thereby extending device lifetime.

3.5 Bad Blocks Management

Bad Blocks are blocks that contain one or more invalid bits whose reliability are not guaranteed. The Bad Blocks may be presented while the SSD is shipped, or may develop during the lifetime of the SSD. When a Bad Block is detected, it will be flagged as unusable block by firmware. The SSD implement Bad Blocks management that consists of Bad Blocks replacement and Error Correcting to avoid data error occurred. The functions will be enabled automatically to transfer data from Bad Blocks to spare blocks, and correct error bit.

3.6 Garbage Collection/TRIM

Garbage collection and TRIM technology is used to maintain data consistency and perform continual data cleansing on SSDs. It runs as a background process, freeing up valuable controller resources while sorting good data into available blocks, and deleting bad blocks. It also significantly reduces write operations to the drive, thereby increasing the SSD's speed and lifespan.

3.7 End to End Data Path Protection

End-to-end Data Path Protection that secures the data transmission between host system and NAND Flash. In the transmission path, no matter in or out, all buffer and storage implement Error Code Correction that optimizes the data integrity in the whole transmission of SSD.

3.8 Thermal Management

CFexpress 3TE8 has built-in thermal sensor which can detect environment temperature of SSD. In the meantime, firmware will monitor the thermal sensor to prevent any failure of overheating. During extreme temperature, firmware will adjust the data transfer behavior to maintain the SSD's reliable operation.

3.9 iDataGuard

Innodisk's iData Guard is a comprehensive data protection mechanism that functions before and after a sudden power outage to the SSD. Low-power detection terminates data writing before an abnormal power-off, while table-remapping after power-on deletes corrupt data and maintains data integrity. Innodisk's iData Guard provides effective power cycling management, preventing data stored in flash from degrading with use.



3.10 iPower Guard

iPower Guard technology is a set of preventive measures that protect the SSD in an unstable power supply environment. This comprehensive package comprises safeguards for startup and shutdown to maintain device performance and ensure data integrity.

3.11 Thermal Throttling

Thermal throttling is a protective mechanism designed to safeguard components from potential damage caused by excessive temperatures. When an SSD approaches a critical temperature threshold, Innodisk firmware activates the thermal throttling mechanism to regulate the SSD's temperature. Thermal throttling is crucial for SSDs since it prevents drive damage, which could otherwise result in data loss. However, it's worth noting that when thermal throttling is activated, read and write tasks may experience a reduction in speed.

3.12 TCG OPAL

OPAL is a set of specifications for features of data storage devices that enhance security. These specifications are published by the Trusted Computing Group's Storage Work Group. Innodisk 3TE8 is compliant with TCG OPAL 2.0(*1). The capability of TCG OPAL Security mode allows multiple users with independent access control to read/write/erase independent data areas (LBA ranges). Each locking range adjusts by authenticated authority. Note that by default there is a single "Global Range" that encompasses the whole user data area. In TCG Opal Security Mode, Revert, Revert SP and GenKey command can erase all of data including global range and locking range; in the meantime generate the new encrypted key.

*1. You need to install TCG OPAL software to implement OPAL function, which is supplied by TCG OPAL software developed company



4. Installation Requirements

4.1 CFexpress 3TE8 Pin Directions

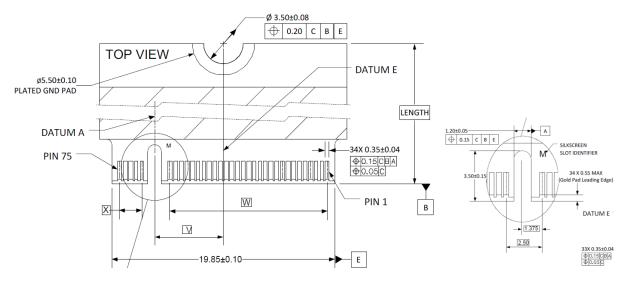


Figure 5: Signal Segment and Power Segment

4.2 Electrical Connections for CFexpress 3TE8

CFexpress 4TE3 is PCIe interface; it follows CFexpress 1.0 type B pin assignment. For pin define please refer to 2.9 Pin Assignment.

4.3 Device Drive

CFexpress 3TE8 is compliant with NVMe 1.4. Both Operation System and BIOS should include NVMe driver to compatible with NVMe device. Nowadays, most of OS includes NVMe in-box driver now. For more information about the driver support in each OS, please visit the website <u>https://nvmexpress.org/drivers/</u>. For BIOS NVMe driver support please contact with motherboard manufacturers.

5. SMART / Health Information

This log page is used to provide SMART and general health information. The information provided is over the life of the controller and is retained across power cycles. More details about Set Features command; please refer to NVM Express 1.4

5.1 Get Log Page (Log Identifier 02h)

Innodisk 3TE8 series SMART / Health Information Log are listed in following table.

Bytes	Description		
	Critical Warning: This field indicates critical warnings for the state of the controller. Each b corresponds to a critical warning type; multiple bits may be set to `1'. If a bit is cleared to `0 then that critical warning does not apply. Critical warnings may result in an asynchronous ever notification to the host. Bits in this field represent the state at the time the Get Log Pag command is processed and may not reflect the state at the time a related asynchronous ever notification, if any, occurs or occurred.		
	Bit	Definition	
	0	If set to `1', then the available spare capacity has fallen below the threshold.	
0	1	If set to `1', then a temperature is:a) greater than or equal to an over temperature threshold.b) less than or equal to an under temperature threshold.	
	2	If set to `1', then the NVM subsystem reliability has been degraded due to significant media related errors or any internal error that degrades NVM subsystem reliability.	
	3	If set to '1', then all of the media has been placed in read only mode. The controller shall not set this bit to '1' if the read-only condition on the media is a result of a change in the write protection state of a namespace.	
	4	If set to `1', then the volatile memory backup device has failed. This field is only valid if the controller has a volatile memory backup solution.	
	5 If set to `1', then the Persistent Memory Region has become read-only of unreliable. 7:6 Reserved		

Table 11: Get Log Page – SMART / Health Information Log

innodi	sk	CFexpress 3TE8										
	Composite Temperature: Contains a value corresponding to a temperature in degrees Kelvin that represents the current composite temperature of the controller and namespace(s)											
1:2	 associated with that controller. The manner in which this value is computed is implementation specific and may not represent the actual temperature of any physical point in the NVM subsystem. The value of this field may be used to trigger an asynchronous event. Warning and critical overheating composite temperature threshold values are reported by the WCTEMP and CCTEMP fields in the Identify Controller data structure. 											
3		re: Contains a normalized percentage (0 to 100%) of the remaining spare										
4	Available Spare Threshold: When the Available Spare falls below the threshold indicated in this field, an asynchronous event completion may occur. The value is indicated as a normalized percentage (0 to 100%). The values 101 to 255 are reserved.											
5	Percentage Used: Contains a vendor specific estimate of the percentage of NVM subsystem life used based on the actual usage and the manufacturer's prediction of NVM life. A value of 100 indicates that the estimated endurance of the NVM in the NVM subsystem has been consumed, but may not indicate an NVM subsystem failure. The value is allowed to exceed 100. Percentages greater than 254 shall be represented as 255. This value shall be updated once per power-on hour (when the controller is not in a sleep state). Refer to the JEDEC JESD218A standard for SSD device life and endurance measurement techniques.											
	state of Endura set to `1'. If a l Group. Critical v field represent	roup Critical Warning Summary: This field indicates critical warnings for the nce Groups. Each bit corresponds to a critical warning type, multiple bits may be bit is cleared to '0', then that critical warning does not apply to any Endurance warnings may result in an asynchronous event notification to the host. Bits in this the current associated state and are not persistent. '1' in one or more Endurance Groups, then the corresponding bit shall be set to										
	Bit	Definition										
6	0	If set to `1', then the available spare capacity of one or more Endurance Groups has fallen below the threshold.										
	1	Reserved										
	2	If set to '1', then the reliability of one or more Endurance Groups has been degraded due to significant media related errors or any internal error that degrades NVM subsystem reliability.										
	3	If set to '1', then the namespaces in one or more Endurance Groups have been placed in read only mode not as a result of a change in the write protection state of a namespace.										
	7:4 Reserved											

7:31	Reserved						
32:47	Data Units Read: Contains the number of 512 byte data units the host has read from the controller as part of processing a SMART Data Units Read Command; this value does not include metadata. This value is reported in thousands (i.e., a value of 1 corresponds to 1,000 units of 512 bytes read) and is rounded up (e.g., one indicates that the number of 512 byte data units read is from 1 to 1,000, three indicates that the number of 512 byte data units read is from 2,001 to 3,000). Refer to the specific I/O Command Set specification for the list of SMART Data Units Read Commands that affect this field. A value of 0h in this field indicates that the number of SMART Data Units Read is not reported.						
48:63	Data Units Written: Contains the number of 512 byte data units the host has written to the controller as part of processing a User Data Out Command; this value does not include metadata. This value is reported in thousands (i.e., a value of 1 corresponds to 1,000 units of 512 bytes written) and is rounded up (e.g., one indicates that the number of 512 byte data units written is from 1 to 1,000, three indicates that the number of 512 byte data units written is from 2,001 to 3,000). Refer to the specific I/O Command Set specification for the list of User Data Out Commands that affect this field. A value of 0h in this field indicates that the number of Data Units Written is not reported.						
64:79	Host Read Commands: Contains the number of SMART Host Read Commands completed by the controller. Refer to the specific I/O Command Set specification for the list of SMART Host Read Commands that affect this field.						
80:95	Host Write Commands: Contains the number of User Data Out Commands completed by the controller. Refer to the specific I/O Command Set specification for the list of User Data Out Commands that affect this field.						
96:111	Controller Busy Time: Contains the amount of time the controller is busy with I/O commands. The controller is busy when there is a command outstanding to an I/O Queue (specifically, a command was issued via an I/O Submission Queue Tail doorbell write and the corresponding completion queue entry has not been posted yet to the associated I/O Completion Queue). This value is reported in minutes.						
112:127	Power Cycles: Contains the number of power cycles.						
128:143	Power On Hours: Contains the number of power-on hours. This may not include time that the controller was powered and in a non-operational power state.						
144:159	Unsafe Shutdowns: Contains the number of unsafe shutdowns. This count is incremented when the controller does not report it is safe to power down prior to loss of main power.						

innodi	SK CFexpress 3TE8											
	Media and Data Integrity Errors: Contains the number of occurrences where the controller											
160:175	detected an unrecovered data integrity error. Errors such as uncorrectable ECC, CRC checksum											
	failure, or LBA tag mismatch are included in this field. Errors introduced as a result of a Write											
	Uncorrectable command (refer to the NVM Command Set Specification) may or may not be											
	included in this field.											
176.101	Number of Error Information Log Entries: Contains the number of Error Information log											
176:191	entries over the life of the controller.											
	Warning Composite Temperature Time: Contains the amount of time in minutes that the											
	controller is operational and the Composite Temperature is greater than or equal to the Warning											
192:195	Composite Temperature Threshold (WCTEMP) field and less than the Critical Composite											
172.175	Temperature Threshold (CCTEMP) field in the Identify Controller data structure in Figure 275.											
	If the value of the WCTEMP or CCTEMP field is 0h, then this field is always cleared to 0h											
	regardless of the Composite Temperature value.											
	Critical Composite Temperature Time: Contains the amount of time in minutes that the											
	controller is operational and the Composite Temperature is greater than or equal to the Critical											
196:199	Composite Temperature Threshold (CCTEMP) field in the Identify Controller data structure.											
	If the value of the CCTEMP field is 0h, then this field is always cleared to 0h regardless of the											
	Composite Temperature value.											
200:201	Temperature Sensor 1: Contains the current temperature reported by the embedded thermal											
200.201	sensor in the controller.											
202:203	Temperature Sensor 2: Contains the current temperature reported by the embedded thermal											
202.203	sensor in the NAND Flash (Channel #0 and CE #0).											
204:205	Temperature Sensor 3: Contains the current temperature reported by the embedded thermal											
204.203	sensor in the NAND Flash (Channel #0 and CE #0).											
206:207	Temperature Sensor 4: Contains the current temperature reported by the embedded thermal											
200.207	sensor in the NAND Flash (Last channel and CE #0).											
208:209	Temperature Sensor 5: Contains the current temperature reported by temperature sensor 5.											
210:211	Temperature Sensor 6: Contains the current temperature reported by temperature sensor 6.											
212:213	Temperature Sensor 7: Contains the current temperature reported by temperature sensor 7.											
214:215	Temperature Sensor 8: Contains the current temperature reported by temperature sensor 8.											
	Thermal Management Temperature 1 Transition Count: Contains the number of times the											
216:219	controller transitioned to lower power active power states or performed vendor specific thermal											
	management actions while minimizing the impact on performance in order to attempt to reduce											
	the Composite Temperature because of the host controlled thermal management feature.											
	Thermal Management Temperature 2 Transition Count: Contains the number of times the											
	controller transitioned to lower power active power states or performed vendor specific thermal											
220:223	management actions regardless of the impact on performance (e.g., heavy throttling) in order											
	to attempt to reduce the Composite Temperature because of the host controlled thermal											
	management feature.											

innodi	CFexpress 3TE8										
	Total Time For Thermal Management Temperature 1: Contains the number of seconds that										
	the controller had transitioned to lower power active power states or performed vendor specific										
224:227	thermal management actions while minimizing the impact on performance in order to attempt to										
	reduce the Composite Temperature because of the host controlled thermal management										
	feature.										
	Total Time For Thermal Management Temperature 2: Contains the number of seconds that										
	the controller had transitioned to lower power active power states or performed vendor specific										
228:231	thermal management actions regardless of the impact on performance (e.g., heavy throttling)										
	in order to attempt to reduce the Composite Temperature because of the host controlled therma										
	management feature.										
232:337	Reserved										
338:345	Later Bad Count										
346:353	Power-On hours Count										
354:361	Drive Power Cycle Count										
362:369	Total Bad Block Count										
370:377	User Max Erase Count										
378:385	User Avg Erase Count										
386:393	Device Life										
394:401	Spare Block Count										
402:409	Program Fail Count										
410:417	Erase Fail Count										
418:425	Unexpected Power Loss Count										
426:433	Temperature (Kelvin - K °K)										
434:441	Flash ID										
442:449	Later Bad Block Info (Read / Write / Erase)										
450:457	Total LBAs Written (unit = 32MB)										
458:465	Total LBAs Read (unit = 32MB)										

6. Part Number Rule

CODE	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	17	18	19	20	21	
	D	Ε	С	F	x	-	Α	2	8	D	S	2	к	С	A	D	L	(W)	-	X	X	
Definition																						
Code 1 st (Disk)										Code 14 th (Operation Temperature)												
D : Disk	D : Disk										C: Standard Grade ($0^{\circ}C \sim +70^{\circ}C$)											
Code 2 nd (Feature set)										Code 15 th (Internal control)												
E : Emb	E : Embedded series									A	~Z: E	BGA F	РСВ \	/ersio	on.							
					For	n fao	ctor)				Code 16 th (Channel of data transfer)											
CFX: CF	expre	ess ty	/pe B	6						D	D: Dual Channels											
										Q	Q: Quad Channels											
		Code	e 7 th	~9 th	י (C a	paci	ty)				Code 17 th (Flash Type)											
A28: 12	8GB									L:	L: Innodisk 3D TLC											
B56: 25	B56: 256GB																					
C12: 51	2GB																					
01T: 1TE	3																					
	Code 10 th ~12 th (Controller)										Code 18 th (Optional Function)											
DS2: PC	DS2: PCIe 3TE8 series with TCG OPAL function									W	W: Write Protect Switch											
Code 13 th (Flash mode)									Code 20 th ~ (Customize code)													
K: 112 Layers 3D TLC																						